

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. <b>247841US6</b>		SERIAL NO. <b>10/760,674</b>	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT <b>Atsushi NOSE, et al.</b>			
				FILING DATE <b>January 21, 2004</b>		GROUP <del>2615</del> <b>2624</b>	
<b>U.S. PATENT DOCUMENTS</b>							
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
/BK/	AA	2004/0247195 A1	12/09/2004	Benoit CHAUVILLE, et al.			
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
<b>FOREIGN PATENT DOCUMENTS</b>							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
/BK/	AO	2001-124517	05/11/2001	JAPAN (with English Abstract and Unedited Computer-Generated English translation)	X		
↓	AP	2-212979	08/24/1990	JAPAN (with English Abstract)			X
	AQ	61-175780	08/07/1986	JAPAN (with English Abstract)			X
	AR	5-274426	10/22/1993	JAPAN (with English Abstract and Unedited Computer-Generated English translation)	X		
	AS	11-149549	06/02/1999	JAPAN (with English Abstract and Unedited Computer-Generated English translation)	X		
	AT	2002-230572	08/16/2002	JAPAN (with English Abstract and Unedited Computer-Generated English translation)	X		
	AU	2004-534489	11/11/2004	JAPAN (corr. US 2004/0247195 A1 and corr. WO 03/007237 A1)			X
	AV	WO 03/007237 A1	01/23/2003	WIPO (with English Abstract)			X
	AW	2004-534490	11/11/2004	JAPAN (corr. US 2004/0247195 A1 and corr. WO 03/007238 A1)			X
	AX	WO 03/007238 A1	01/23/2003	WIPO (with English Abstract)			X
/BK/	AY	2004-80545	03/11/2004	JAPAN (with English Abstract and Unedited Computer-Generated English translation)	X		
<b>OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)</b>							
	AZ				<input type="checkbox"/> Additional References sheet(s) attached		
Examiner <b>/Bernard Krasnic/</b>					Date Considered <b>02/04/2008</b>		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							